SSM3K301T

Power Management Switch Applications

High-Speed Switching Applications

Unit: mm

- 1.8 V drive
- Low ON-resistance: R_{on} = 110 mΩ (max) (@V_{GS} = 1.8 V)
  R_{on} = 74 mΩ (max) (@V_{GS} = 2.5 V)
  R_{on} = 56 mΩ (max) (@V_{GS} = 4.0 V)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		V_{DS}	20	V
Gate-Source voltage		V_{GSS}	± 12	V
Drain current	DC	I_D	3.5	A
	Pulse	I_{DP}	7.0	
Drain power dissipation		$P_{D\ (Note\ 1)}$	700	mW
Channel temperature		T_{ch}	150	°C
Storage temperature range		T_{stg}	−55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the TY Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Mounted on an FR4 board.
(25.4 mm × 25.4 mm × 1.6 t, Cu Pad: 645 mm^2)

1. GATE
2. SOURCE
3. DRAIN
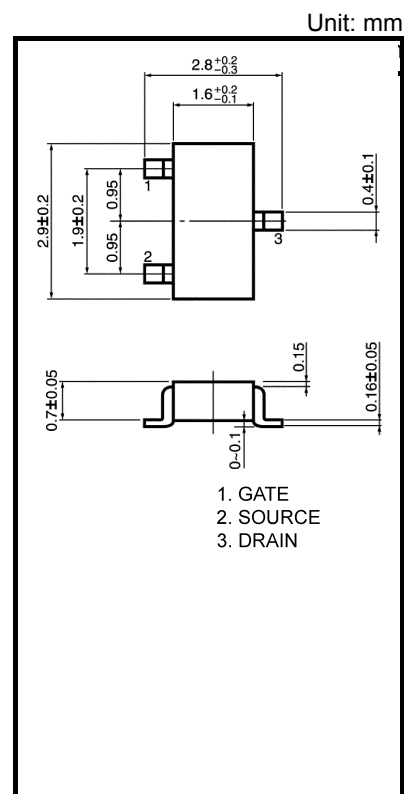
Weight: 10 mg (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition		Min	Typ.	Max	Unit
Drain-Source breakdown voltage		$V_{(BR)DSS}$	I_D = 1 mA, V_{GS} = 0		20	—	—	V
		$V_{(BR)DSX}$	I_D = 1 mA, V_{GS} = −12 V		12	—	—	
Drain cutoff current		I_{DSS}	V_{DS} = 20 V, V_{GS} = 0		—	—	1	μA
Gate leakage current		I_{GSS}	V_{GS} = ±12 V, V_{DS} = 0		—	—	±1	μA
Gate threshold voltage		V_{th}	V_{DS} = 3 V, I_D = 1 mA		0.4	—	1.0	V
Forward transfer admittance		$|Y_{fs}|$	V_{DS} = 3 V, I_D = 2.0 A	(Note 2)	6	10	—	S
Drain-Source ON-resistance		$R_{DS(ON)}$	I_D = 2.0 A, V_{GS} = 4.0 V	(Note 2)	—	44	56	mΩ
			I_D = 1.0 A, V_{GS} = 2.5 V	(Note 2)	—	53	74	
			I_D = 0.5 A, V_{GS} = 1.8 V	(Note 2)	—	70	110	
Input capacitance		C_{iss}	V_{DS} = 10 V, V_{GS} = 0, f = 1 MHz		—	320	—	pF
Output capacitance		C_{oss}			—	62	—	
Reverse transfer capacitance		C_{rss}			—	51	—	
Total Gate Charge		Q_g	V_{DS} = 10 V, I_{DS} = 3.5 A V_{GS} = 4 V		—	4.8	—	nC
Gate-Source Charge		Q_{gs}			—	3.3	—	
Gate-Drain Charge		Q_{gd}			—	1.5	—	
Switching time	Turn-on time	t_{on}	V_{DD} = 10 V, I_D = 2 A, V_{GS} = 0~2.5 V, R_G = 4.7 Ω		—	18	—	ns
	Turn-off time	t_{off}			—	14	—	
Drain-Source forward voltage		V_{DSF}	I_D = −3.5 A, V_{GS} = 0 V	(Note 2)	—	−0.85	−1.2	V

Note 2: Pulse test

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Switching Time Test Circuit

(a) Test Circuit

2.5 V

0

10 µs

IN

OUT

R_G

V_DD
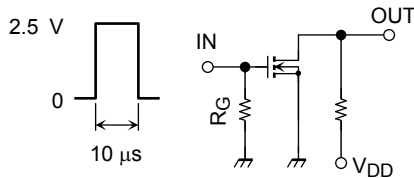
$V_{DD} = 10\ V$
$R_G = 4.7\ \Omega$
$D.U. \leqq 1\%$
$V_{IN}: t_r, t_f < 5\ ns$
Common Source
$Ta = 25°C$

(b) V_IN

2.5 V

0 V

90%

10%

V_DD

10%

90%

$V_{DS\ (ON)}$

t_r

t_f

t_{on}

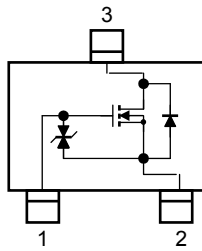t_{off}

(c) V_OUT

Marking

3

KK4

1   2
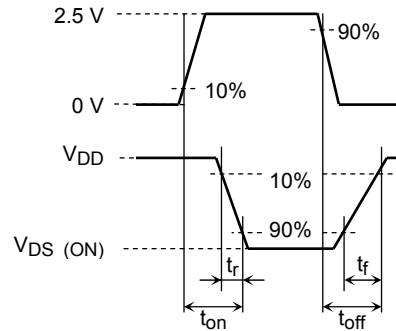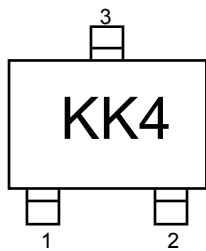
Equivalent Circuit (top view)

3

1   2

Notice on Usage

V_{th} can be expressed as the voltage between gate and source when the low operating current value is $I_D = 1$ mA for this product. For normal switching operation, $V_{GS\ (on)}$ requires a higher voltage than V_{th}, and $V_{GS\ (off)}$ requires a lower voltage than V_{th}. (The relationship can be established as follows: $V_{GS\ (off)} < V_{th} < V_{GS\ (on)}$.)
Take this into consideration when using the device.

Handling Precaution

When handling individual devices that are not yet mounted on a circuit board, make sure that the environment is protected against electrostatic discharge. Operators should wear antistatic clothing, and containers and other objects that come into direct contact with devices should be made of antistatic materials.